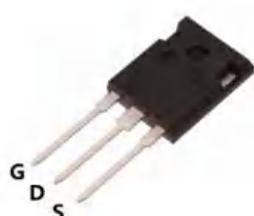


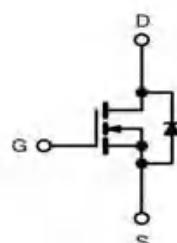
Type: YZPST-65R72GF

N-channel Power MOSFET

PRODUCT SUMMARY	
V_{DS} (V) at T_J max.	700
$R_{DS(on)}$ max. at 25°C ($\text{m}\Omega$)	$V_{GS}=10\text{V}$ 72
Q_g max. (nC)	130
Q_{gs} (nC)	30
Q_{gd} (nC)	34
Configuration	single



TO-247



Schematic diagram

Features

- Fast Body Diode MOSFET
- $I_D=4.7\text{A}(V_{GS}=10\text{V})$
- Ultra Low Gate Charge
- Improved dv/dt Capability
- RoHS compliant

Applications

- Switching Mode Power Supplies (SMPS)
- Server and Telecom Power Supplies
- Welding & Battery Chargers
- Solar(PV Inverters)
- AC/DC Bridge Circuits

ORDERING INFORMATION

Device	YZPST-65R72GF
Device Package	TO-247
Marking	65R72GF

ABSOLUTE MAXIMUM RATINGS ($T_c = 25^\circ\text{C}$, unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain to Source Voltage	V_{DSS}	650	V
Continuous Drain Current (@ $T_c=25^\circ\text{C}$)	I_D	47 ⁽¹⁾	A
Continuous Drain Current (@ $T_c=100^\circ\text{C}$)		29 ⁽¹⁾	A
Drain current pulsed ⁽²⁾	I_{DM}	138 ⁽¹⁾	A
Gate to Source Voltage	V_{GS}	± 30	V
Single pulsed Avalanche Energy ⁽³⁾	E_{AS}	1500	mJ
MOSFET dv/dt ruggedness (@ $V_{DS}=0\text{~}400\text{V}$)	dv/dt	25	V/ns
Peak diode Recovery dv/dt ⁽⁴⁾	dv/dt	15	V/ns
Total power dissipation (@ $T_c=25^\circ\text{C}$)	P_D	417	W
Derating Factor above 25°C		3.34	W/°C
Operating Junction Temperature & Storage Temperature	T_{STG}, T_J	-55 to + 150	°C
Maximum lead temperature for soldering purpose	T_L	260	°C

Notes

1. Drain current is limited by maximum junction temperature.
2. Repetitive rating : pulse width limited by junction temperature.
3. $L = 37\text{mH}$, $I_{AS} = 9\text{A}$, $V_{DD} = 50\text{V}$, $R_G=25\Omega$, Starting at $T_J = 25^\circ\text{C}$
4. $I_{SD} \leq I_D$, $dV/dt = 100\text{A}/\mu\text{s}$, $V_{DD} \leq BV_{DSS}$, Starting at $T_J = 25^\circ\text{C}$

THERMAL CHARACTERISTICS

Parameter	Symbol	Value	Unit
Thermal resistance, Junction to case	R _{thjc}	0.33	°C/W
Thermal resistance, Junction to ambient	R _{thja}	40	°C/W

ELECTRICAL CHARACTERISTICS (T_C = 25°C unless otherwise specified)

Parameter	Symbol	Test conditions	Min.	Typ.	Max.	Unit
Off Characteristics						
Drain to source breakdown voltage	BV _{DSS}	V _{GS} =0V, I _D =250uA	650	--	--	V
Breakdown voltage temperature coefficient	ΔBV _{DSS} / ΔT _J	I _D =250uA, referenced to 25°C	--	0.7	--	V/°C
Drain to source leakage current	I _{DSS}	V _{DS} =650V, V _{GS} =0V	--	--	10	uA
		V _{DS} =520V, T _C =125°C	--	75	500	uA
Gate to source leakage current, forward	I _{GSS}	V _{GS} =30V, V _{DS} =0V	--	--	150	nA
Gate to source leakage current, reverse		V _{GS} =-30V, V _{DS} =0V	--	--	-150	nA
On Characteristics						
Gate threshold voltage	V _{GS(TH)}	V _{DS} =V _{GS} , I _D =250uA	2.5	--	4.5	V
Drain to source on state resistance	R _{DS(ON)}	V _{GS} =10V, I _D =24A	--	60	72	mΩ
Forward Transconductance	G _{fs}	V _{DS} = 30 V, I _D = 24A	--	32	--	S
Dynamic Characteristics						
Input capacitance	C _{iss}	V _{GS} =0V, V _{DS} =200V, f=1MHz	--	4655	--	pF
Output capacitance	C _{oss}		--	185	--	
Reverse transfer capacitance	C _{rss}		--	5.1	--	
Turn on delay time	t _{d(on)}	V _{DS} =380V, I _D =24A , R _G =25Ω	--	34	--	ns
Rising time	t _r		--	31	--	
Turn off delay time	t _{d(off)}		--	80	--	
Fall time	t _f		--	26	--	
Total gate charge	Q _g	V _{DS} =520V, V _{GS} =10V, I _D =24A	--	104	130	nC
Gate-source charge	Q _{gs}		--	30	--	
Gate-drain charge	Q _{gd}		--	34	--	

SOURCE TO DRAIN DIODE RATINGS CHARACTERISTICS

Parameter	Symbol	Test conditions	Min.	Typ.	Max.	Unit
Continuous source current	I _s	Integral reverse p-n Junction diode in the MOSFET	--	--	47	A
Pulsed source current	I _{SM}		--	--	138	A
Diode forward voltage drop.	V _{SD}	I _s =24A, V _{GS} =0V	--	0.9	1.2	V
Reverse recovery time	T _{rr}	I _s =24A, V _{GS} =0V, dI/dt=100A/us	--	230	320	ns
Reverse recovery Charge	Q _{rr}		--	2.7	5.0	uC

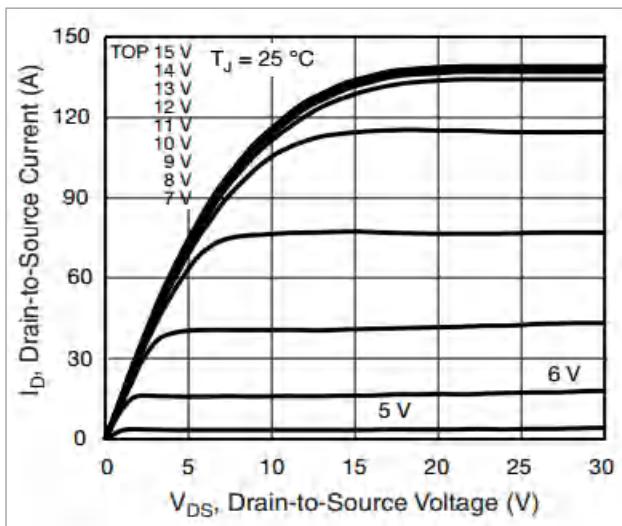
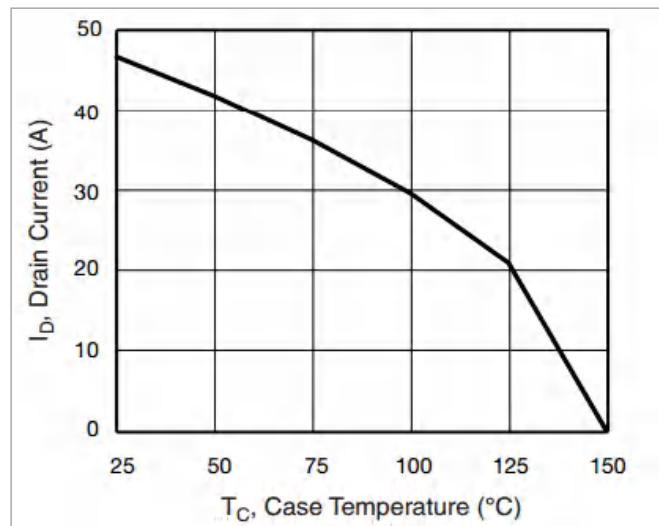
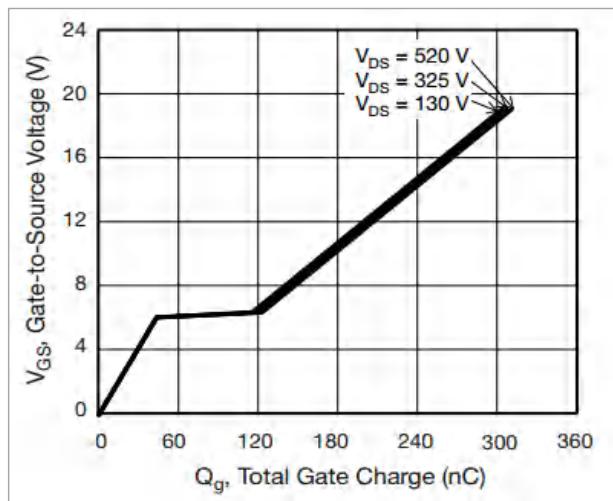
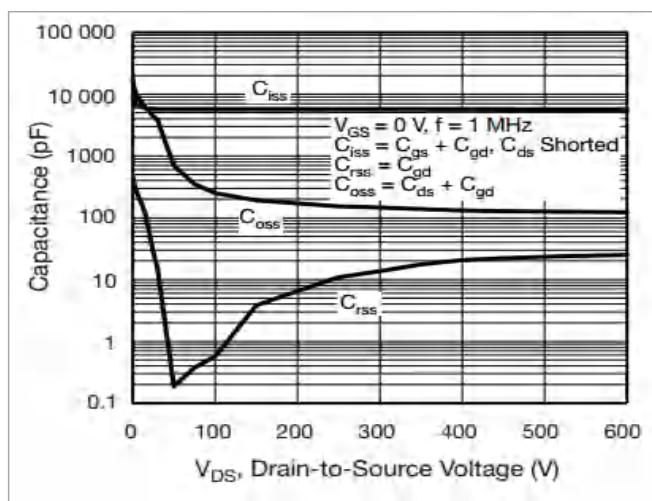
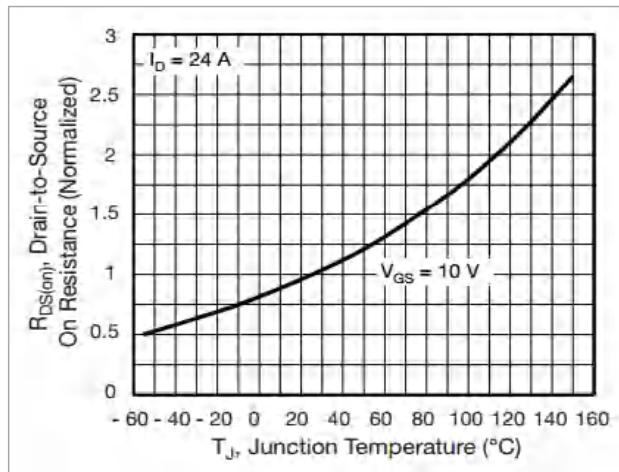
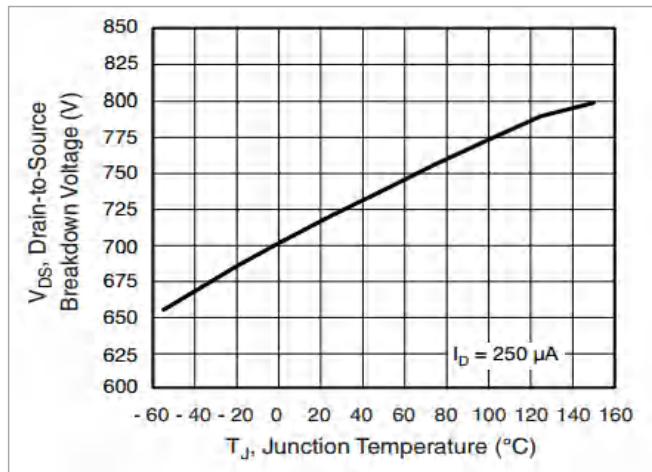
Fig1. Output characteristics**Fig2. - Maximum Drain Current vs. Case Temperature****Fig3. Gate charge characteristics****Fig 4. Capacitance Characteristics****Fig 5. Rds(ON) vs junction temperature****Fig 6. - Temperature vs. Drain-to-Source Voltage**

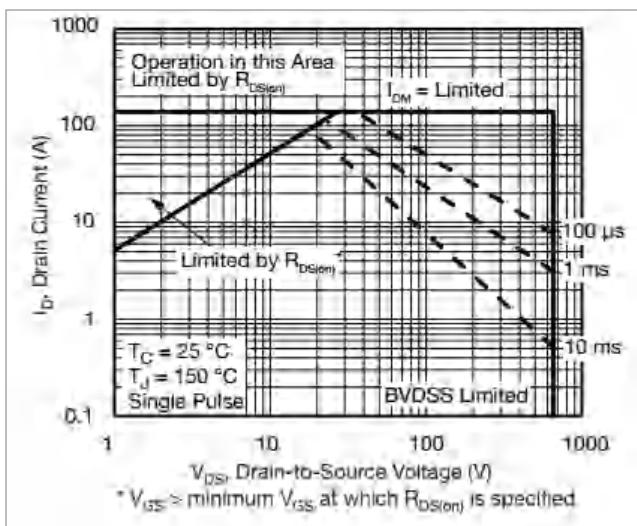
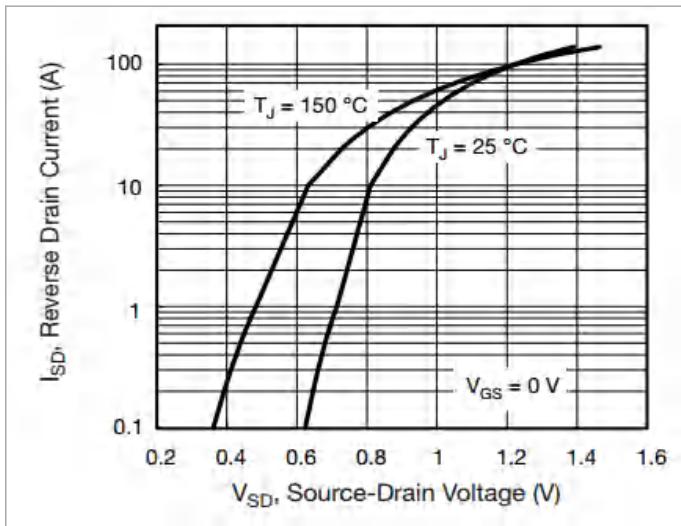
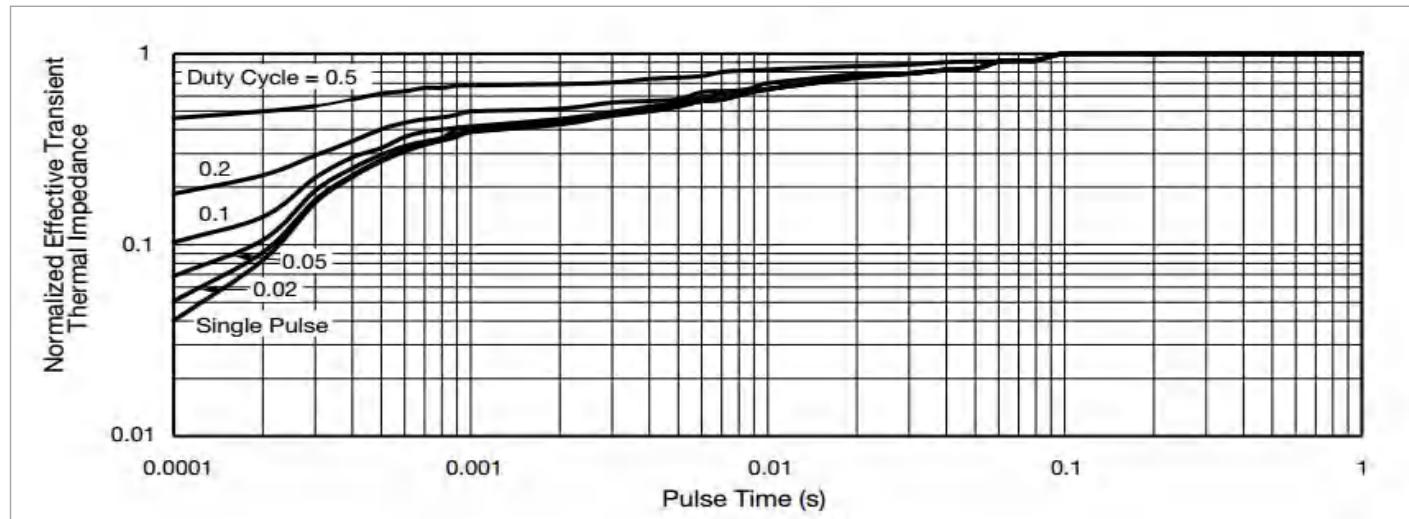
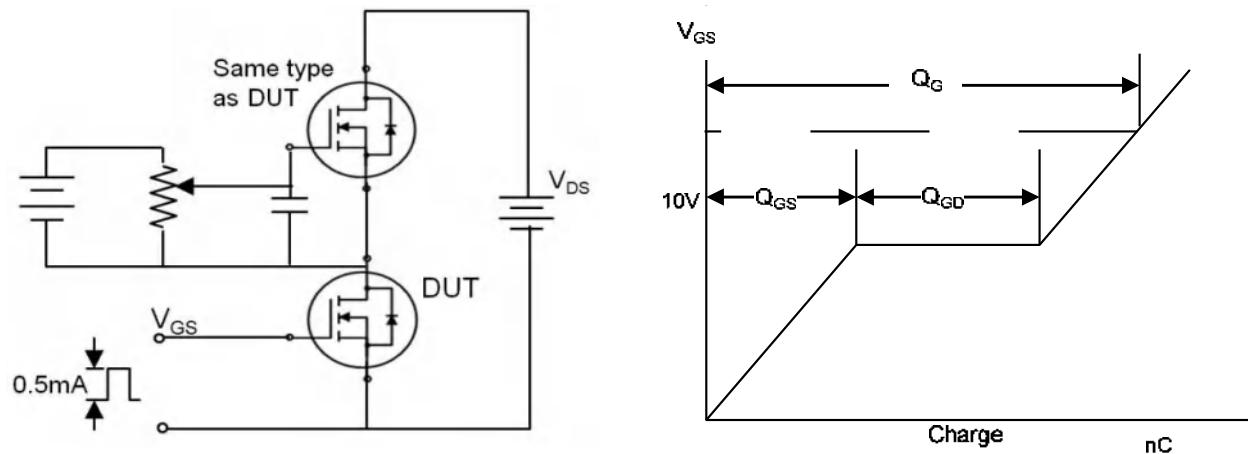
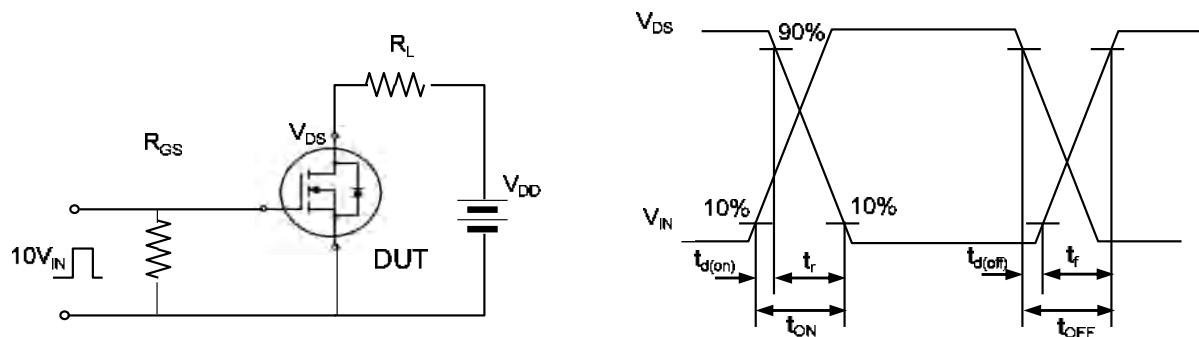
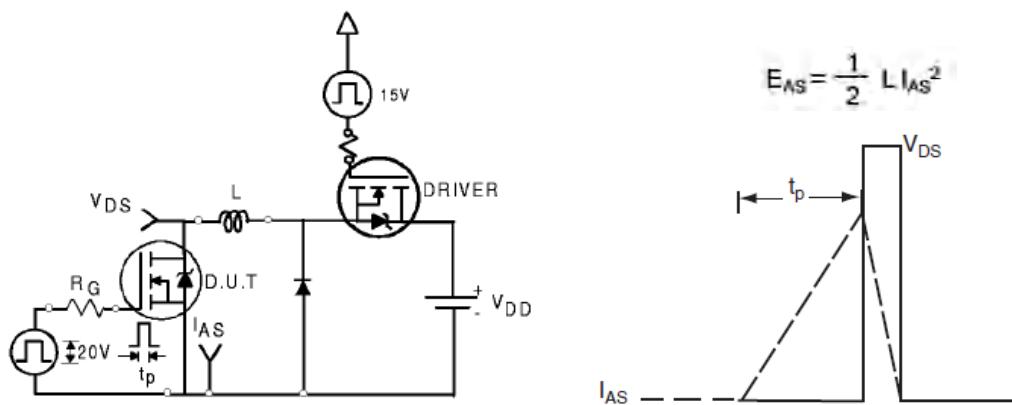
Fig 7 . Safe operating area**Fig 8. Forward characteristics of reverse diode****Fig 9 . Transient thermal impedance****Fig 10. Gate charge test circuit & waveform**

Fig 11. Switching time test circuit & waveform**Fig 12. Unclamped Inductive switching test circuit & waveform****Fig 13. Peak diode recovery dv/dt test circuit & waveform**